Seal	rch Note	es

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/821,231	ZHANG ET AL.	
Examiner	Art Unit	-
F. L. Evans	2877	•

SEARCHED				
Class	Subclass	Date	Examiner	
356	36,38,301, 244	8/1/2006	FLE	
SEARCH	UPDATED	1/31/2007	FLE	
		<del></del>		
· 4. =				
÷				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	· I		
			1

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM-TDB) - SEE SEARCH HISTORY PRINTOUT	8/1/2006	FLE
EAST (USPAT, US-PGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM- TDB) - SEE SEARCH HISTORY PRINTOUT	1/31/2007	FLE
CONSULTED TC2800 101 HELP PANEL	1/31/2007	FLE
	-	
· · · · · · · · · · · · · · · · · · ·		